O 1 P E AUG 1 7 2005 W

5

10

15

20

25

30

## Claim Listing for Application Serial No. 10/786,424 for Amendment in Response to Office Action of 04/14/2005

- 1. (Currently Amended) A plasma chamber enclosure structure for use in an RF plasma reactor which includes a pedestal adapted to support a workpiece to be processed, a reactor base housing the pedestal, and a coil antenna adjacent the reactor and which is adapted to inductively couple RF power into the reactor, said plasma chamber enclosure structure comprising:
- a) said plasma chamber enclosure structure being a singlewall dielectric enclosure structure;
- b) said plasma chamber enclosure structure being of an inverted cup-shape configuration;
- c) said plasma chamber enclosure comprising a ceiling comprising:
  - (i) a centrally located gas inlet; and
- (ii) an interior surface comprising a flattened conical configuration extending to said gas inlet such that when positioned over the base said interior surface is more distant from the pedestal over a center of the pedestal and closer to the pedestal over a periphery of the pedestal;
- d) said plasma chamber enclosure structure having a sidewall, said sidewall comprising:
- (i) a lower cylindrical portion generally transverse to the pedestal when positioned over the base; and
- (ii)e) said plasma chamber enclosure structure having a transitional portion between connecting said lower cylindrical portion and said ceiling, said transitional portion extending inwardly from said lower cylindrical portion, said transitional portion extending inward comprising a radius of curvature;
- $\underline{f}e$ ) said plasma chamber enclosure structure being adapted to cover the reactor base to comprise the RF plasma reactor;

- gf) said plasma chamber enclosure structure being adapted to define a plasma-processing volume over the pedestal;
- $\underline{h}\underline{g}$ ) said plasma chamber enclosure structure being capable of transmitting inductive power therethrough from an adjacent antenna:
- $\underline{i}h$ ) said plasma chamber enclosure structure being formed of a dielectric material selected from a group consisting of silicon, silicon carbide, quartz, and alumina; and
- j±) said interior surface of said ceiling of said flattened
  conical configuration being a substantial portion of said
  interior surface of said ceiling.

15

- 2. (Original) The enclosure structure of Claim 1 being adapted to be positioned adjacent the antenna.
- 3. (Original) The enclosure structure of Claim 2 wherein said dielectric material consists of alumina.
- 4. (Original) The enclosure structure of Claim 1 wherein said dielectric material consists of alumina.
- 5. (Original) The enclosure structure of Claim 1 being integrally formed of one of a) alumina, or b) silicon.
- 6. (Original) The enclosure structure of Claim 1 wherein said top wall and said side wall consist of silicon.
  - 7. (Original) The enclosure structure of Claim 1 further comprising a conductive ceiling portion in a facing relationship to the pedestal when positioned over the base.

- 8. (Original) The enclosure structure of Claim 7 wherein said conductive ceiling portion is adapted to be coupled to a bias power source.
- 9. (Original) The enclosure structure of Claim 1 wherein said ceiling comprises conductive material and is adapted to be coupled to a bias power source.
  - 10. (Original) The enclosure structure of Claim 1 having a generally right circular cylindrical configuration.
- 11. (Currently Amended) A plasma chamber dome for an RF plasma

  10 reactor which includes a pedestal adapted to support a workpiece to

  be processed, a reactor base housing the pedestal, and a coil

  antenna adjacent the reactor and which is adapted to inductively

  couple RF power into the reactor, said dome comprising:
  - a) said dome having an inverted cup-shape configuration having top and side walls in a generally right circular cylindrical configuration;
    - b) said top wall comprising:

15

20

- (i) a centrally located gas inlet; and
- (ii) a substantially flat interior surface extending to said gas inlet, said substantially flat interior surface of said top wall having at least a portion extending in a direction away from said centrally located gas inlet with an angle of declination toward the pedestal;
  - c) said sidewall comprising:
- (i) a lower cylindrical portion generally transverse to the pedestal when positioned over the base; and
  - (ii) d) said dome comprising a transitional portion between connecting said lower cylindrical portion and said top wall, said transitional portion \_extending inwardly from said lower

cylindrical portion, said transitional portion extending inward comprising at least one radius of curvature;

 $\underline{ed}$ ) said dome being adapted so as to be capable of having said top wall in a facing relationship to the pedestal when positioned over the base;

5

- $\underline{f}e$ ) said dome being adapted to define a plasma-processing volume over the pedestal;
- gf) said dome being adapted to cover the reactor base to comprise the RF plasma reactor;
- 10 <u>hg</u>) said dome being capable of transmitting inductive power therethrough from an adjacent antenna;
  - $\underline{i}h$ ) said top wall and said side wall being formed of a dielectric material selected from a group consisting of silicon, silicon carbide, quartz, alumina, and sapphire; and
- 15 <u>j</u>±) said substantially flat interior surface being a substantial portion of said interior surface of said top wall.
  - 12. (Original) The plasma chamber dome of Claim 11 wherein said top wall and said side wall consist of silicon.
- 13. (Original) The plasma chamber dome of Claim 11 wherein said top wall and said side wall consist of alumina.
  - 14. (Original) The plasma chamber dome of Claim 11 being integrally formed of one of a) alumina, or b) silicon.
  - 15. (Original) The plasma chamber dome of Claim 11 further comprising a flange portion extending radially outward from said side wall.
    - 16. (Original) The plasma chamber dome of Claim 15 wherein said top wall and said side wall consist of silicon.

- 17. (Original) The plasma chamber dome of Claim 15 wherein said top wall and said side wall consist of alumina.
- 18. (Original) The plasma chamber dome of Claim 15 wherein said top wall and said side wall consist of alumina.
- 19. (Original) The plasma chamber dome of Claim 11 comprising a conductive ceiling portion in a facing relationship to the pedestal when positioned over the base.
  - 20. (Original) The plasma chamber dome of Claim 19 wherein said conductive ceiling portion is adapted to be coupled to a bias power source.

15

20

- 21. (Original) The plasma chamber dome of Claim 11 wherein said top wall comprises conductive material, said top wall being adapted to be coupled to a bias power source.
- 22. (Currently Amended) An RF plasma reactor which includes a pedestal adapted to support a workpiece to be processed, a reactor base housing the pedestal, and a coil antenna adjacent the reactor and which is adapted to inductively couple RF power into the reactor, the reactor comprising:
- a) a single-wall dielectric enclosure structure of an inverted cup-shaped configuration having a ceiling comprising a centrally located gas inlet and comprising an interior surface comprising a conical profile extending to said gas inlet;
- b) said single-wall dielectric enclosure structure having a side wall comprising a cylindrical portion generally transverse to the pedestal when positioned over the base and comprising a transition portion extending inward from said cylindrical

portion, said transition portion extending inward comprising at least one radius of curvature;

c) said single-wall dielectric enclosure structure being adapted to cover the reactor base to comprise the RF plasma reactor;

5

10

15

- d) said single-wall dielectric enclosure structure being adapted to define a plasma-processing volume over the pedestal;
- e) said single-wall dielectric enclosure structure being capable of transmitting inductive power therethrough from an adjacent antenna;
- f) said single-wall dielectric enclosure structure being formed of a dielectric material selected from a group consisting of silicon, silicon carbide, quartz, and alumina; and
- g) said ceiling of said conical profile being a substantial portion of said ceiling.
  - 23. (Original) The reactor of Claim 22 wherein said ceiling when position over the base is in spaced facing relationship to the pedestal.
- 24. (Original) The reactor of Claim 23 wherein said enclosure structure consists of alumina.
  - 25. (Original) The reactor of Claim 23 wherein said side wall is adapted to be positioned adjacent the antenna.
- 26. (Original) The reactor of Claim 22 wherein said enclosure structure has a generally right circular cylindrical configuration.
  - 27. (Original) The reactor of Claim 22 wherein said dielectric consists of alumina.

- 28. (Original) The reactor of Claim 22 wherein said single-walled dielectric enclosure structure is integrally formed of one of a) alumina, or b) silicon.
- 5 29. (Original) The reactor of Claim 22 comprising a conductive ceiling portion in a facing relationship to the pedestal when positioned over the base.

- 30. (Original) The reactor of Claim 29 wherein said conductive ceiling portion is adapted to be coupled to a bias power source.
- 31. (Original) The reactor of Claim 22 wherein said ceiling comprises a conductive material and is adapted to be coupled to a bias power source.